

<b>Notice of References Cited</b>	Application/Control No. 10/750,141		Applicant(s)/Patent Under Reexamination YAMAKAWA ET AL.	
	Examiner Daniel C. McCracken		Art Unit 1793	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,515,339	02-2003	Shin et al.	257/368
*	B	US-6,737,939	05-2004	Hoppe et al.	333/186
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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